

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/614,085	AWASAKA ET AL.	
			Examiner	Art Unit	Page 1 of 1
			Sheldon J Richter	3748	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,684,863	02-2004	Dixon et al.	123/565
*	B	US-6,651,432	11-2003	Gray, Jr., Charles L.	123/564
*	C	US-6,626,164	09-2003	Hitomi et al.	123/679
*	D	US-6,058,708	05-2000	Heinitz et al.	60/602
*	E	US-5,345,920	09-1994	Sugino et al.	123/564
*	F	US-5,307,783	05-1994	Satoya et al.	123/564
*	G	US-5,297,532	03-1994	Ikebe et al.	123/564
*	H	US-4,428,352	01-1984	Mayer et al.	123/564
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 10266878 A	10-1998	Japan	TANAHASHI, TOSHIO	F02D 13/02
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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